TOSHIBA HIGH EFFICIENCY DIODE STACK (HED) SILICON EPITAXIAL TYPE

# 30JL2C41

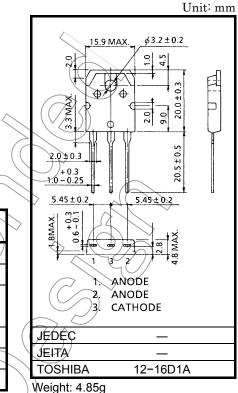
#### SWITCHING MODE POWER SUPPLY APPLICATON CONVERTER & CHOPPER APPLICATION

- Repetitive Peak Reverse Voltage  $: V_{RRM} = 600 V$
- Average Output Rectified Current : I<sub>O</sub> = 30 A
- Ultra Fast Reverse-Recovery Time  $: t_{rr} = 50 \text{ ns} (Max)$
- Low Switching Losses and Output Noise

TOSHIBA

#### ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

Screw Torque		0.8	<b>∕</b> N·m
Storage Temperature Range	T <sub>stg</sub>	-40~150	°C
Junction Temperature	Тj	40~150	°C
Peak One Cycle Surge Forward Current (Sine Wave)	IFSM	150 (50Hz) 165 (60Hz)	A
Average Output Rectified Current	Ι <sub>Ο</sub>	30	A
Repetitive Peak Reverse Voltage	V <sub>RRM</sub>	600	V V
CHARACTERISTIC	SYMBOL	RATING	TIMU



Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report

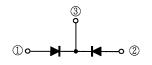
and estimated failure rate, etc).

### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	MAX	UNIT
Peak Forward Voltage	VFM	I <sub>FM</sub> = 15A	_	2.0	V
Repetitive Peak Reverse Current	IRRM	V <sub>RRM</sub> = 600V	_	50	μA
Reverse Recovery time	tin	I <sub>F</sub> = 2A, di / dt = -50A / μs	_	50	ns
Forward Recovery time	tfr	I <sub>F</sub> = 1A	_	150	ns
Thermal Resistance	R <sub>th (j-c)</sub>	Total DC, Junction to Case		1.0	°C / W

V<sub>FM</sub>, I<sub>RRM</sub>, t<sub>rr</sub>, t<sub>fr</sub> : A value applied to one cell.

#### POLARITY

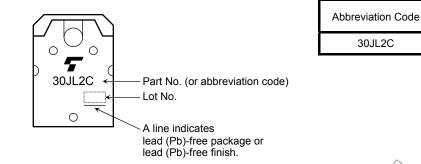


## **TOSHIBA**

Part No.

30JL2C41

#### MARKING



Handling	Precaution

The absolute maximum ratings denote the absolute maximum ratings, which are rated values and must not be exceeded during operation, even for an instant. The following are the general derating methods that we recommend when you design a circuit with a device.

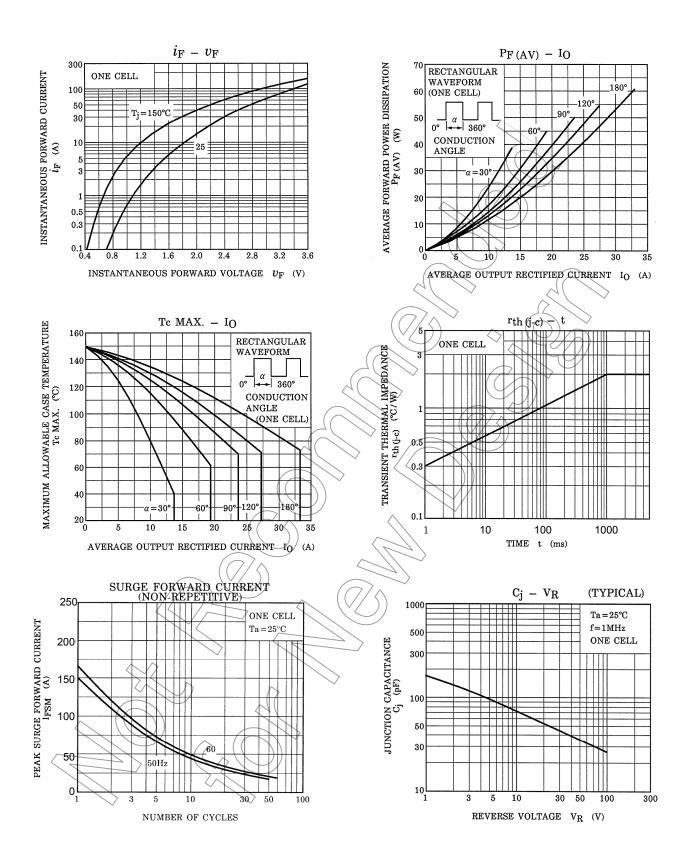
- VRRM: We recommend that the worst case voltage, including surge voltage, be no greater than 80% of the absolute maximum rating of VRRM for a DC circuit and be no greater than 50% of that of VRRM for an AC circuit. VRRM has a temperature coefficient of 0.1%/°C./Take this temperature coefficient into account designing a device at low temperature.
- IO: We recommend that the worst case current be no greater than 80% of the absolute maximum rating of IO. Carry out adequate heat design. If you can't design a circuit with excellent heat radiation, set the margin by using an allowable Tamax-IO curve.

This rating specifies the non-repetitive peak current in one cycle of a 50-Hz sine wave, condition angle 180. Therefore, this is only applied for an abnormal operation, which seldom occurs during the lifespan of the device.

We recommend that a device be used at a Tj of below 120°C under the worst load and heat radiation conditions.

Please refer to the Rectifiers databook for further information.)

## TOSHIBA



#### **RESTRICTIONS ON PRODUCT USE**

Handbook" etc.

The information contained herein is subject to change without notice.

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- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
  In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability
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